

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/045,348	SHIN ET AL.
	Examiner	Art Unit
	Mark A. Mais	2619

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See Attached Electronic Search	9/15/2006	MAM
See Inventorship Search	6/16/2007	MAM
See Attached Electronic Search [updated]	6/16/2007	MAM
See Attached Electronic Search [updated]	12/11/2007	MAM